



MAX3221E SLLS686C - OCTOBER 2005 - REVISED JULY 2021

MAX3221E 3-V to 5.5-V Single-Channel RS-232 Line Driver/Receiver With ±15-kV IEC ESD Protection

1 Features

- ESD protection for RS-232 pins
 - ±15-kV Human-body model (HBM)
 - ±8 kV (IEC 61000-4-2, Contact discharge)
 - ±15 kV (IEC 61000-4-2, Air-gap discharge)
- Meets or exceeds the requirements of TIA/ EIA-232-F and ITU v.28 standards
- Operates with 3-V to 5.5-V V_{CC} upply
- Operates up to 250 kbit/s
- One driver and one receiver
- Low standby current: 1 µA typical
- Accepts 5-V logic input with 3.3-V supply
- Auto-power-down feature automatically disables drivers for power savings
- Alternative high-speed device (1 Mbit/s)
 - SN75C3221E and SN65C3221E

2 Applications

- **Industrial PCs**
- Wired networking
- Data center and enterprise computing
- Battery-powered systems
- **PDAs**
- **Notebooks**
- Laptops
- Palmtop PCs
- Hand-held equipment

3 Description

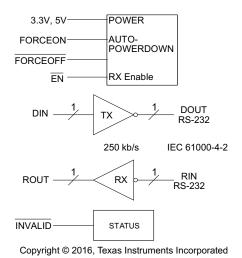
The MAX3221E is a single driver, single receiver RS-232 solution operating from a single V_{CC} supply. The RS-232 pins provide IEC 61000-4-2 ESD protection. The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. These devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

Flexible control options for power management are available. Auto-power down disables driver and charge pump when the receiver is disconnected or the remote driver is power down. The drivers can be manually enabled or disabled. INVALID output goes low when receiver input is unconnected or power off.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
MAX3221ECDB, MAX3221EIDB	SSOP (16)	6.20 mm × 5.30 mm
MAX3221ECPW, MAX3221EIPW	TSSOP (16)	5.00 mm × 4.40 mm

For all available packages, see the orderable addendum at the end of the data sheet



Block Diagram



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NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

• •	or E. Fage Hambers for provided revisions may affect from page Hambers in the carrent version.	
С	hanges from Revision B (March 2016) to Revision C (July 2021)	Page
•	Changed the Applications list	1
•	Added ESD ratings IEC Specifications table and added a table note for the minimum requirement to IEC ESD level	
•	Changed values in the Thermal Information table for DB and PW packages	
С	hanges from Revision A (May 2006) to Revision B (March 2016)	Page
С	hanges from Revision A (May 2006) to Revision B (March 2016)	Page
•	Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and	
	Implementation section, Power Supply Recommendations section, Layout section, Device and	
	Documentation Support section, and Mechanical, Packaging, and Orderable Information section	1
•	Deleted Ordering Information table; see the POA at the end of the data sheet	1
•	Changed R _{B,IA} thermal values: 82 to 92 for DB package and 108 to 100.3 for PW Package	



5 Pin Configuration and Functions

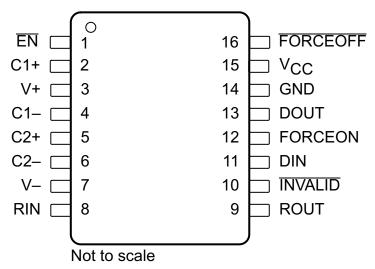


Figure 5-1. DB or PW Package, 16-Pin SSOP or TSSOP, Top View

Table 5-1. Pin Functions

PIN NAME NO.		1/0	DESCRIPTION		
		I/O			
C1+	— Positive terminals of the voltage-doubler charge pump capacitors		Positive terminals of the voltage doubler charge numb capacitors		
C2+	5	_	Positive terminals of the voltage-doubler charge pump capacitors		
C1-	4		Negative terminals of the voltage-doubler charge pump capacitors		
C2-	6		Integrative terminals of the voltage-doubler charge pump capacitors		
DIN	11	I	Driver input		
DOUT	13	0	RS-232 driver output		
EN	1	I	Low input enables receiver ROUT output. High input sets ROUT to high impedance.		
FORCEOFF	16	I	Automatic power-down control input		
FORCEON	12	I	Automatic power-down control input		
GND	14	_	Ground		
INVALID	10	0	Invalid output pin. Output low when RIN input is unpowered.		
RIN	8	I	RS-232 receiver input		
ROUT	9	0	Receiver output		
V _{CC}	15	_	3-V to 5.5-V supply voltage		
V+	3	0	5.5-V supply generated by the charge pump		
V–	7	0	-5.5-V supply generated by the charge pump		



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage ⁽²⁾		-0.3	6	V
V+	Positive output supply voltage ⁽²⁾	Positive output supply voltage ⁽²⁾			V
V-	Negative output supply voltage ⁽²⁾		0.3	-7	V
V+ – V–	Supply voltage difference ⁽²⁾			13	V
1/	Input veltage	DIN, FORCEOFF, FORCEON, EN	-0.3	6	V
V _I	Input voltage	RIN	-25	25	, v
1/	Output valtage	DOUT	-13.2	13.2	V
Vo	Output voltage ROUT, INVALID		-0.3	V _{CC} + 0.3	V
TJ	Operating virtual junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

	o) discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	Pins 8 and 11	±15000	
V _(ESD)			All other pins	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	All pins	±1500	

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 ESD Ratings - IEC Specifications

				VALUE	UNIT
V (700)	Electrostatio dispharge	IEC 61000-4-2 Contact Discharge, DOUT and RIN ⁽¹⁾	Ding 9 and 11	±8000	V
V (ESD)	1	IEC 61000-4-2 Air-Gap Discharge, DOUT and RIN ⁽¹⁾	Pins 8 and 11	±15000	V

(1) A minimum of 1-µF capacitor is required between VCC and GND to meet the specified IEC-ESD level.

⁽²⁾ All voltages are with respect to network GND.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.4 Recommended Operating Conditions

See Figure 9-1 (1)

				MIN	NOM	MAX	UNIT
	Supply voltage		V _{CC} = 3.3 V	3	3.3	3.6	V
	Supply voltage	V _{CC} = 5 V	4.5	5	5.5	V	
V _{IH}	Driver and control high-level input voltage	DIN, FORCEOFF, FORCEON, EN	V _{CC} = 3.3 V	2			V
			V _{CC} = 5 V	2.4			
V _{IL}	Driver and control low-level input voltage	DIN, FORCEOFF, FORCEON, EN				0.8	V
VI	Driver and control input voltage	DIN, FORCEOFF, FORCEON		0		5.5	V
VI	Receiver input voltage			-25		25	V
_	Operating free air temperature	MAX3221EC		0		70	°C
T _A	Operating free-air temperature	MAX3221EI		-40		85	30

⁽¹⁾ Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

6.5 Thermal Information

		MAX	MAX3221E		
	THERMAL METRIC(1)	DB (SSOP)	PW (TSSOP)	UNIT	
		16 PINS	16 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	105.8	110.9	°C/W	
R _{θJC(top)}	Junction-to-case (top) thermal resistance	51.9	41.7	°C/W	
R _{θJB}	Junction-to-board thermal resistance	57.6	57.2	°C/W	
ΨЈТ	Junction-to-top characterization parameter	14.1	4.2	°C/W	
ΨЈВ	Junction-to-board characterization parameter	56.8	56.6	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

6.6 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(2)

PARAMETER			TEST CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
I	Input leakage current	FORCEOFF, FORCEON, EN				±0.01	±1	μΑ
		Auto-power down disabled		No load, FORCEOFF and FORCEON at V _{CC}		0.3	1	mA
I _{CC}	Supply current Powered off $V_{CC} = 3.3 \text{ V}$ Auto-power down enabled $V_{T_A} = 25^{\circ}\text{C}$	V _{CC} = 3.3 V or 5 V, T _A = 25°C	No load, FORCEOFF at GND		1	10		
				No load, FORCEOFF at V _{CC} , FORCEON at GND, All RIN are open or grounded		1	10	μΑ

All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.



6.7 Electrical Characteristics: Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3)

	PARAMETER	TEST	CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	DOUT at $R_L = 3 \text{ k}\Omega$ to GND,	DIN = GND		5	5.4		V
V _{OL}	Low-level output voltage	DOUT at R_L = 3 kΩ to GND,	DIN = V _{CC}		– 5	-5.4		V
I _{IH}	High-level input current	V _I = V _{CC}				±0.01	±1	μΑ
I _{IL}	Low-level input current	V _I = GND				±0.01	±1	μA
	Short-circuit	V _{CC} = 3.6 V,	V _O = 0 V			±35	±60	mA
los	output current ⁽²⁾	V _{CC} = 5.5 V,	V _O = 0 V			±35	±60	IIIA
r _o	Output resistance	V _{CC} , V+, and V- = 0 V,	V _O = ±2 V		300	10M		Ω
1	Output leakage current	FORCEOFF = GND	V _O = ±12 V,	V _{CC} = 3 V to 3.6 V			±25	
I _{off}	Output leakage current	put leakage current FORCEOFF - GND	$V_0 = \pm 10 \text{ V},$	V _{CC} = 4.5 V to 5.5 V			±25	μA

- (1) All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25 ^{\circ}\text{C}$.
- (2) Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.
- (3) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

6.8 Electrical Characteristics: Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(2)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	High-level output voltage	I _{OH} = -1 mA	V _{CC} - 0.6	V _{CC} - 0.1		V
V _{OL}	Low-level output voltage	I _{OL} = 1.6 mA			0.4	V
V _{IT+}	Positive-going input threshold voltage	V _{CC} = 3.3 V		1.6	2.4	V
VIT+		V _{CC} = 5 V		1.9	2.4	V
V	/ _{IT} Negative-going input threshold voltage	V _{CC} = 3.3 V	0.6	1.1		V
VII-		V _{CC} = 5 V	0.8	1.4		V
V _{hys}	Input hysteresis (V _{IT+} - V _{IT-})			0.5		V
I _{off}	Output leakage current	EN = V _{CC}		±0.05	±10	μΑ
ri	Input resistance	V _I = ±3 V to ±25 V	3	5	7	kΩ

- (1) All typical values are at $V_{CC} = 3.3 \text{ V}$ or $V_{CC} = 5 \text{ V}$, and $T_A = 25^{\circ}\text{C}$.
- (2) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V.

6.9 Electrical Characteristics: Auto-Power Down

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CON	MIN	MAX	UNIT	
V _{T+(valid)}	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND, F	ORCEOFF = V _{CC}		2.7	V
V _{T-(valid)}	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND, F	ORCEOFF = V _{CC}	-2.7		V
V _{T(invalid)}	Receiver input threshold for I NVALID low-level output voltage	FORCEON = GND, F	ORCEOFF = V _{CC}	-0.3	0.3	V
V _{OH}	INVALID high-level output voltage	I_{OH} = -1 mA, FORCEON = FORCEOFF = V_{CC}	GND,	V _{CC} - 0.6		V
V _{OL}	INVALID low-level output voltage	I_{OL} = 1.6 mA, FORCEON = FORCEOFF = V_{CC}	= GND,		0.4	V



6.10 Switching Characteristics: Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽³⁾

	PARAMETER	TE	TEST CONDITIONS					
	Maximum data rate	C _L = 1000 pF,	$R_L = 3 k\Omega$,	150	250		kbit/s	
t _{sk(p)}	Pulse skew ⁽²⁾	C _L = 150 pF to 2500 pF,	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$ See Figure 7-2		100		ns	
25"	Slew rate,	V _{CC} = 3.3 V,	C _L = 150 pF to 1000 pF	6		30		
SR(tr)	transition region (see Figure 7-1)	D 0101 710	C _L = 150 pF to 2500 pF	4		30	V/µs	

- (1) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.
- Pulse skew is defined as $|t_{PLH}-t_{PHL}|$ of each channel of the same device. Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

6.11 Switching Characteristics: Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)(3)

	PARAMETER	TEST CONDITIONS	TYP ⁽¹⁾	UNIT
t _{PLH}	Propagation delay time, low- to high-level output	C _L = 150 pF, See Figure 7-3	150	ns
t _{PHL}	Propagation delay time, high- to low-level output	C _L = 150 pF, See Figure 7-3	150	ns
t _{en}	Output enable time	C_L = 150 pF, R_L = 3 k Ω , See Figure 7-4	200	ns
t _{dis}	Output disable time	C_L = 150 pF, R_L = 3 k Ω , See Figure 7-4	200	ns
t _{sk(p)}	Pulse skew ⁽²⁾	See Figure 7-3	50	ns

- All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.
- (2)
- Pulse skew is defined as $|t_{PLH}-t_{PHL}|$ of each channel of the same device. Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V.

6.12 Switching Characteristics: Auto-Power Down

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

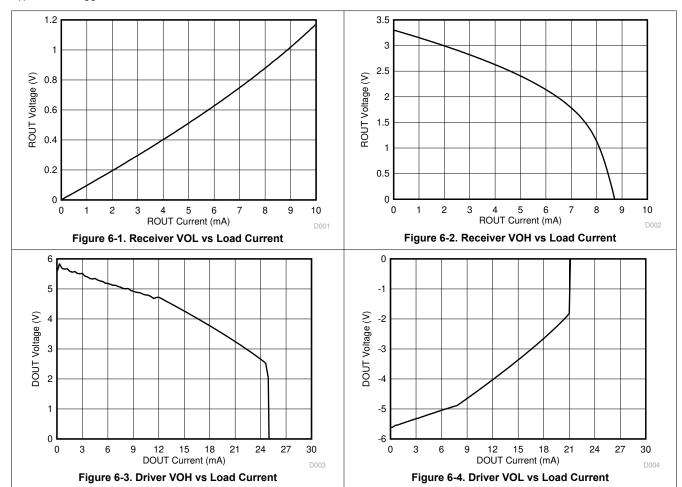
	PARAMETER						
t _{valid}	Propagation delay time, low- to high-level output	1	μs				
t _{invalid}	Propagation delay time, high- to low-level output	30	μs				
t _{en}	Supply enable time	100	μs				

All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.



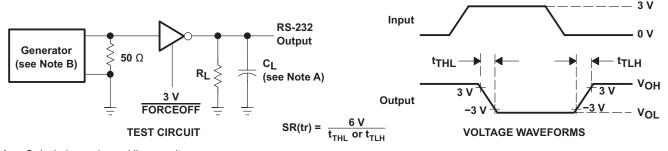
6.13 Typical Characteristics

 $T_A = 25^{\circ} C; V_{CC} = 3.3V$



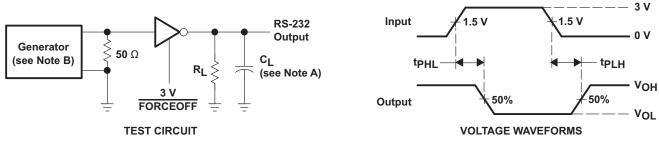


7 Parameter Measurement Information



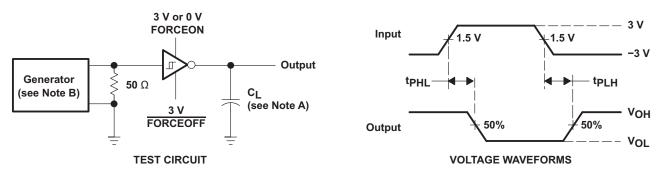
- C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbps, $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 7-1. Driver Slew Rate



- C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbps, Z_0 = 50 Ω , 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

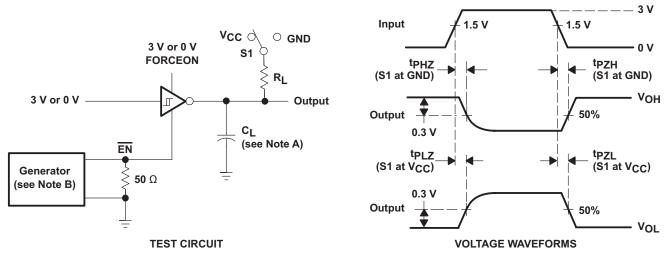
Figure 7-2. Driver Pulse Skew



- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 7-3. Receiver Propagation Delay Times





- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: $Z_0 = 50 \ \Omega$, 50% duty cycle, $t_r \le 10 \ ns$, $t_f \le 10 \ ns$.
- C. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- D. t_{PZL} and t_{PZH} are the same as t_{en} .

Figure 7-4. Receiver Enable and Disable Times

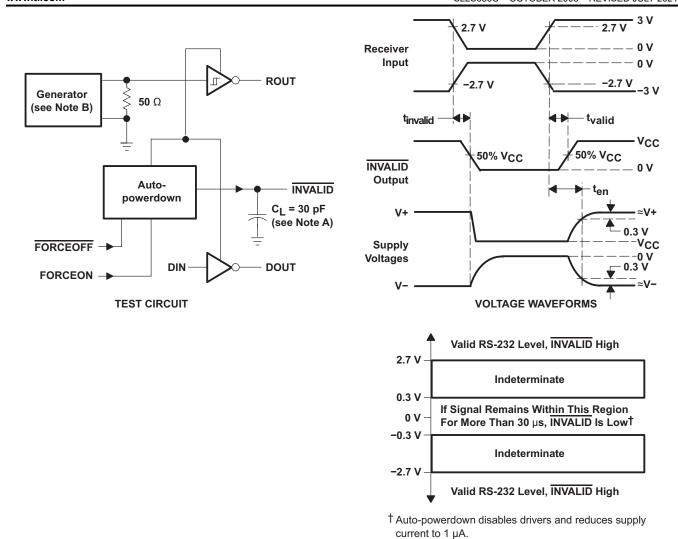


Figure 7-5. INVALID Propagation Delay Times and Driver Enabling Time

8 Detailed Description

8.1 Overview

The MAX3221E is a single driver, single receiver RS-232 solution operating from a single V_{CC} supply. The RS-232 pins provide IEC 61000-4-2 ESD protection. The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. These devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/ μ s driver output slew rate.

Flexible control options for power management are available when the serial port is inactive. The auto-power-down feature functions when FORCEON is low and $\overline{\text{FORCEOFF}}$ is high. During this mode of operation, if the device does not sense a valid RS-232 signal on the receiver input, the driver output is disabled. If $\overline{\text{FORCEOFF}}$ is set low and $\overline{\text{EN}}$ is high, both the driver and receiver are shut off, and the supply current is reduced to 1 μ A. Disconnecting the serial port or turning off the peripheral drivers causes the auto-power-down condition to occur. Auto-power down can be disabled when FORCEON and $\overline{\text{FORCEOFF}}$ are high. With auto-power down enabled, the device is activated automatically when a valid signal is applied to the receiver input. The $\overline{\text{INVALID}}$ output notifies the user if an RS-232 signal is present at the receiver input. $\overline{\text{INVALID}}$ is high (valid data) if the receiver input voltage is greater than 2.7 V or less than -2.7 V, or has been between -0.3 V and 0.3 V for less than 30 μ s. $\overline{\text{INVALID}}$ is low (invalid data) if the receiver input voltage is between -0.3 V and 0.3 V for more than 30 μ s. See Figure 7-1 for receiver input levels.

8.2 Functional Block Diagram

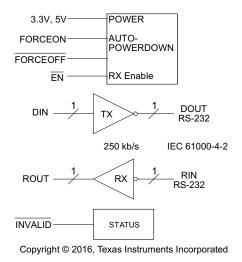


Figure 8-1. Logic Diagram (Positive Logic)

8.3 Feature Description

8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge pump that requires four external capacitors. Auto-power-down feature for driver is controlled by FORCEON and $\overline{\text{FORCEOFF}}$ inputs. Receiver is controlled by $\overline{\text{EN}}$ input. When MAX3221E is unpowered, it can be safely connected to an active remote RS-232 device.

8.3.2 RS-232 Driver

One driver interfaces standard logic levels to RS-232 levels. DIN input must be valid high or low.

8.3.3 RS-232 Receiver

One receiver interfaces RS-232 levels to standard logic levels. An open input results in a high output on ROUT. RIN input includes an internal standard RS-232 load. A logic high input on the EN pin shuts down the receiver output.

8.3.4 RS-232 Status

The INVALID output goes low when RIN input is unpowered for more than 30 μs. The INVALID output goes high when receiver has a valid input. The INVALID output is active when V_{cc} is powered irregardless of FORCEON and FORCEOFF inputs (see Table 8-3).

8.4 Device Functional Modes

Table 8-1, Table 8-2, and Table 8-3 show the behavior of the driver, receiver, and INVALID features under all possible relevant combinations of inputs.

INPUTS OUTPUT **DRIVER STATUS VALID RIN DOUT FORCEON FORCEOFF** DIN RS-232 LEVEL Χ Ζ Χ Х Powered off L Н Χ Н Normal operation with auto-power down disabled Н Н Н Х L L Yes Н L Η Normal operation with auto-power down enabled Н L Н Yes L Ζ L Powered off by auto-power down feature Н L Ζ No

Table 8-1. Function Tables Each Driver(1)

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

Table 8-2. Each Receiver⁽¹⁾

	INPUTS								
RIN	ĒN	VALID RIN RS-232 LEVEL	OUTPUT ROUT						
L	L	X	Н						
Н	L	Х	L						
Х	Н	Х	Z						
Open	L	No	Н						

H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = disconnected input or connected driver off

Table 8-3. INVALID (1)

INPUTS	OUTPUT			
RIN	FORCEON	FORCEOFF	EN	INVALID
L	X	X	X	Н
Н	X	X	X	Н
Open	X	X	X	L

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off



9 Application and Implementation

Note

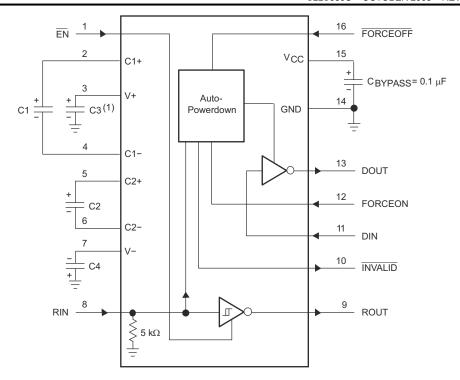
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The MAX3221E line driver and receiver is a specialized device for 3-V to 5.5-V RS-232 communication applications. This application is a generic implementation of this device with all required external components. For proper operation, add capacitors as shown in Figure 9-1.

9.2 Typical Application

ROUT and DIN connect to UART or general purpose logic lines. FORCEON and $\overline{\text{FORCEOFF}}$ may be connected general purpose logic lines or tied to ground or V_{CC} . $\overline{\text{INVALID}}$ may be connected to a general purpose logic line or left unconnected. RIN and DOUT lines connect to a RS-232 connector or cable. DIN, FORCEON, and $\overline{\text{FORCEOFF}}$ inputs must not be left unconnected.



- (1) C3 can be connected to $V_{\mbox{\footnotesize CC}}$ or GND.
- NOTES: A. Resistor values shown are nominal.
 - B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

V_{CC} vs CAPACITOR VALUES

Vcc	C1	C2, C3, and C4
3.3 V ± 0.3 V 5 V ± 0.5 V	0.1 μF 0.047 μF	0.1 μF 0.33 μF
3 V to 5.5 V	0.1 μF	0.47 μF

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Figure 9-1. Typical Operating Circuit and Capacitor Values

9.2.1 Design Requirements

- Recommended V_{CC} is 3.3 V or 5 V.
 - 3 V to 5.5 V is also possible
- · Maximum recommended bit rate is 250 kbps.
- Use capacitors as shown in Figure 9-1.

9.2.2 Detailed Design Procedure

- DIN, FORCEOFF and FORCEON inputs must be connected to valid low or high logic levels.
- Select capacitor values based on VCC level for best performance.



9.2.3 Application Curves

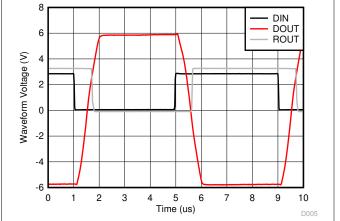


Figure 9-2. Loopback Waveforms V_{CC} = 3.3 V, Data Rate 250 kbit/s

Figure 9-3. Loopback Waveforms with 1-nF load V_{CC} = 3.3 V, Data Rate 250 kbit/s



10 Power Supply Recommendations

TI recommends a 0.1-µF capacitor to filter noise on the power supply pin. For additional filter capability, a 0.01-µF capacitor may be added in parallel as well. Power supply input voltage is recommended to be any valid level in Section 6.4.

11 Layout

11.1 Layout Guidelines

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times. Make the impedance from MAX3221E ground pin and circuit board's ground plane as low as possible for best ESD performance. Use wide metal and multiple vias on both sides of ground pin.

11.2 Layout Example

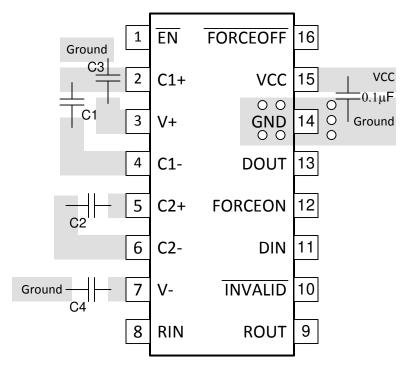


Figure 11-1. MAX3221E Layout Example



12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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12.3 Trademarks

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12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
MANAGOAFORRA	A OT!) /F	0000		40	0000	D 110 0 0	(6)		0.4.70	MPONEO	
MAX3221ECDBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Samples
MAX3221ECDBRG4	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Samples
MAX3221ECPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP221EC	Samples
MAX3221EIDBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Samples
MAX3221EIDBRG4	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Samples
MAX3221EIPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Samples
MAX3221EIPWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP221EI	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

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(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION



TAPE DIMENSIONS KO PI BO BO Cavity AO

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3221ECDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3221ECPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3221EIPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3221EIPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



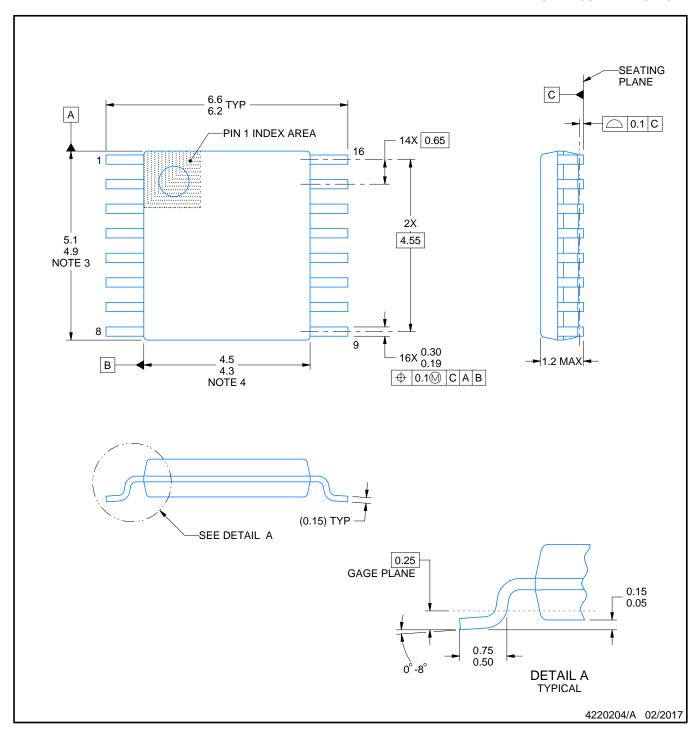
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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3221ECDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3221ECPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3221EIDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3221EIPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3221EIPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3221EIPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0





NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



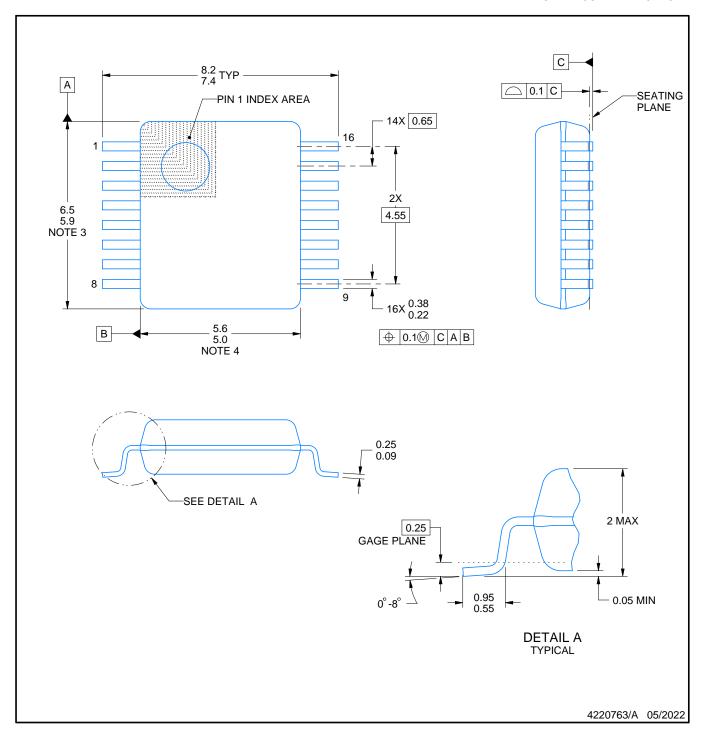


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







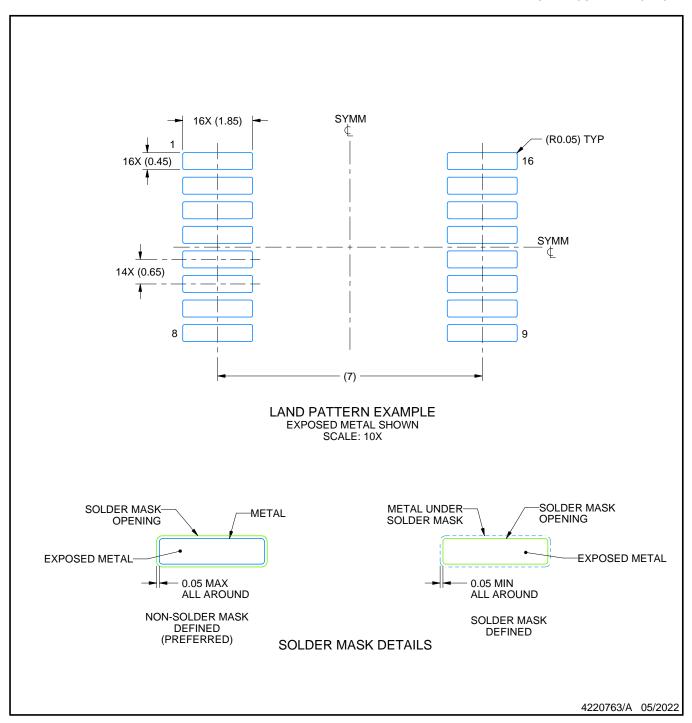
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.

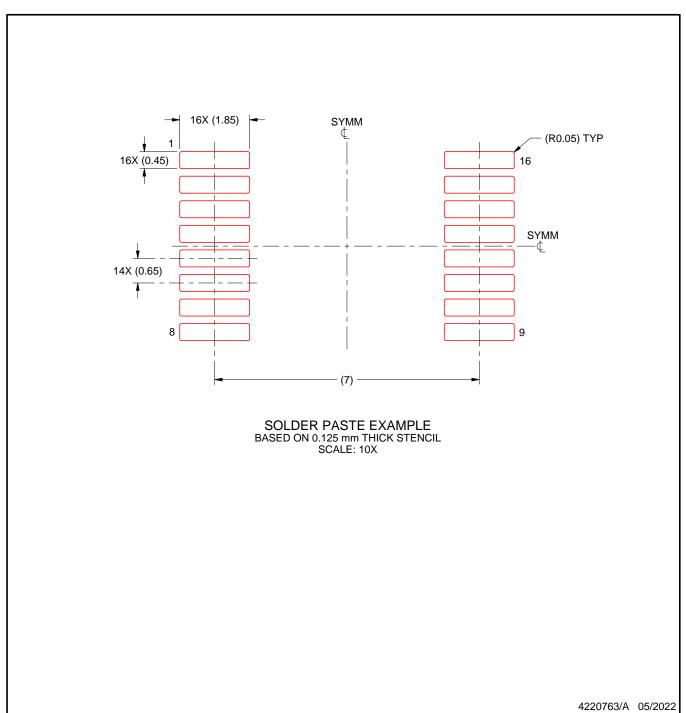




NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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